Celltech Intro and Engineering Service Let	Date(s) of Evaluation October 15 & 26, 2010	<u>Test Report Serial No.</u> 092110Q2G-T1048b-S24M	<u>Test Report Revision No.</u> Rev. 1.0 (Initial Release)	
	Test Report Issue Date December 19, 2010	Description of Test(s) Specific Absorption Rate	RF Exposure Category Gen. Pop. / Uncontrolled	Test Lab Certificate No. 2470.01

**APPENDIX G - PROBE CALIBRATION** 

Applicant:	Xplor	olore Technologies Corp. FCC ID: Q2GGOBI2K-XPL IC: 4596A-GOBI2KXPI		lore Technologies Corp. FCC I		4596A-GOBI2KXPL	
DUT Type: GOBI2000 Mini-PCI Express WWAN Card in iX104C5 Tablet PC with Non Pump-Up Antenna							TECHNOLOGIES.
2010 Celltech Labs Inc. This document is not to be reproduced in whole or in part without the prior written permission of Celltech Labs Inc.						Page 55 of 56	

#### Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



SNISS CPR 20 PR/BRAT

S Schweizerischer Kalibrierdienst C Service suisse d'étalonnage Servizio svizzero di taratura

S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

#### Client Celltech

Certificate No: ET3-1590\_Jul10

Dbject	ET3DV6 - SN:1	<b>590</b> - 11 - 24 - 44 - 14 - 14 - 14 - 14	
alibration procedure(s)		QA CAL-12.v8, QA CAL-23.v3 an edure for dosimatric E-field probe	
alibration date:	July 15, 2010		
	-	tional standards, which realize the physical uni probability are given on the following pages an	. ,
Il calibrations have been condu	ucted in the closed laborate	bry facility: environment temperature (22 $\pm$ 3)°C	C and humidity < 70%.
All calibrations have been condu Calibration Equipment used (M&		ory facility: environment temperature (22 ± 3)°C	C and humidity < 70%.
alibration Equipment used (M8		ory facility: environment temperature (22 ± 3)°0 Cal Date (Certificate No.)	C and humidity < 70%. Scheduled Calibration
alibration Equipment used (M8	TE critical for calibration)		
Calibration Equipment used (M8 Primary Standards Power meter E4419B	TE critical for calibration)	Cal Date (Certificate No.)	Scheduled Calibration
alibration Equipment used (M8 trimary Standards lower meter E4419B lower sensor E4412A	TE critical for calibration)	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136)	Scheduled Calibration Apr-11
Calibration Equipment used (M8 Trimary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A	TE critical for calibration) ID # GB41293874 MY41495277	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136)	Scheduled Calibration Apr-11 Apr-11
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136)	Scheduled Calibration Apr-11 Apr-11 Apr-11
	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c)	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b)	Cal Date <u>(Certificate No.)</u> 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Mar-11
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5056 (20b) SN: S5129 (30b)	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Mar-11 Mar-11
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Mar-11 Dec-10
alibration Equipment used (M8 rimary Standards ower meter E4419B ower sensor E4412A ower sensor E4412A eference 3 dB Attenuator eference 20 dB Attenuator eference 30 dB Attenuator eference Probe ES3DV2 AE4 econdary Standards	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 20-Apr-10 (No. DAE4-660_Apr10)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Apr-11 Scheduled Check
alibration Equipment used (M8 rimary Standards ower meter E4419B ower sensor E4412A ower sensor E4412A teference 3 dB Attenuator teference 20 dB Attenuator teference 30 dB Attenuator teference Probe ES3DV2 tAE4 econdary Standards F generator HP 8648C	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 ID #	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 20-Apr-10 (No. DAE4-660_Apr10) Check Date (in house)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Apr-11 Scheduled Check In house check: Oct-11
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4 Recondary Standards Reference HP 8648C	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 ID # US3642U01700	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 20-Apr-10 (No. DAE4-660_Apr10) Check Date (in house) 4-Aug-99 (in house check Oct-09)	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Apr-11 Scheduled Check In house check: Oct-11
alibration Equipment used (M8 rimary Standards ower meter E4419B ower sensor E4412A ower sensor E4412A eference 3 dB Attenuator eference 20 dB Attenuator eference 20 dB Attenuator eference 30 dB Attenuator eference Probe ES3DV2 AE4 <u>econdary Standards</u> F generator HP 8648C etwork Analyzer HP 8753E	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 ID # US3642U01700 US37390585	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 20-Apr-10 (No. DAE4-660_Apr10) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09)	Scheduled Calibration Apr-11 Apr-11 Mar-11 Mar-11 Mar-11 Dec-10 Apr-11 Scheduled Check In house check: Oct-11 In house check: Oct10
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 ID # US3642U01700 US37390585 Name	Cal Date (Certificate No.) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 20-Apr-10 (No. DAE4-660_Apr10) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09) Function	Scheduled Calibration Apr-11 Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Apr-11 Scheduled Check In house check: Oct-11 In house check: Oct10

#### Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst

- C Service suisse d'étalonnage
- Servizio svizzero di taratura
- S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization 9	9 rotation around an axis that is in the plane normal to probe axis (at measurement center),
	i.e., $9 = 0$ is normal to probe axis

#### Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

#### Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization θ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx, y, z are only intermediate values, i.e., the uncertainties of NORMx, y, z does not effect the E<sup>2</sup>-field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)x,y,z* = *NORMx,y,z* \* *frequency\_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCPx,y,z*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

# Probe ET3DV6

## SN:1590

Manufactured: Last calibrated: Recalibrated:

March 19, 2001 July 16, 2009 July 15, 2010

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

## DASY/EASY - Parameters of Probe: ET3DV6 SN:1590

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (μV/(V/m) <sup>2</sup> ) <sup>A</sup>	1.86	2.06	1.77	± 10.1%
DCP (mV) <sup>3</sup>	91,4	92.4	83.5	

#### **Modulation Calibration Parameters**

UID	Communication System Name	PAR		A dB	B dBuV	С	VR mV	Unc <sup>E</sup> (k=2)
10000	cw	0.00	х	0.00	0.00	1.00	300.0	± 1.5%
			Y	0.00	0.00	1.00	300.0	
			Z	0.00	0.00	1.00	300.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

The uncertainties of NormX,Y.Z do not affect the E<sup>3</sup>-field uncertainty inside TSL (see Pages 5 and 6)

 $<sup>^\</sup>circ$  Numerical linearization parameter: uncertainty not required.

<sup>&</sup>lt;sup>1</sup> Uncertainty is determined using the maximum deviation from linear response applying recatangular distribution and is expressed for the square of the field value.

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## DASY/EASY - Parameters of Probe: ET3DV6 SN:1590

Calibration Parameter Determined in Head Tissue Simulating Media

## 

f [MHz]	Validity [MHz] <sup>C</sup>	Permittivity	Conductivity	ConvFX Cor	nvFY Co	nvF Z	Alpha	Depth Unc (k=2)
450	± 50 / ± 100	<b>4</b> 3.5 ± 5%	0.87 ± 5%	7.25	7.25	7.25	0.20	2.19 ± 13.3%
835	± 50 / ± 100	<b>4</b> 1.5 ± 5%	0.90 ± 5%	6.27	6.27	6.27	0.32	2.49 ± 11.0%
900	± 50 / ± 100	<b>4</b> 1.5 <b>±</b> 5%	0.97 ± 5%	6.12	6.12	6.12	0.27	2.86 ± 11.0%

<sup>2</sup> The validity of ± 100 MHz only applies for DASY v4 4 and higher (see Page 2) The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band

## DASY/EASY - Parameters of Probe: ET3DV6 SN:1590

#### Calibration Parameter Determined in Body Tissue Simulating Media

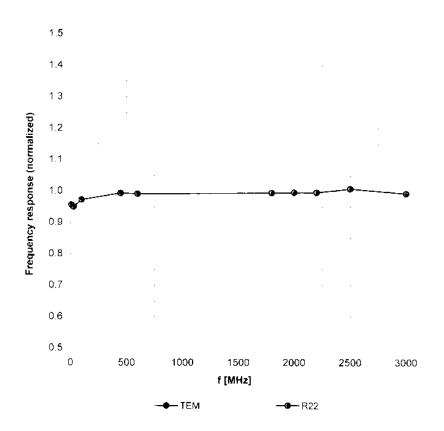
f [MHz]	Validity [MHz] <sup>C</sup>	Permittivity	Conductivity	ConvF X Cor	IVFY Co	nvF Z	Alpha	Depth Unc (k=2)
450	± 50 / ± 100	56.7 ± 5%	0.94 ± 5%	7.73	7.73	7.73	0.13	2.06 ± 13.3%
835	± 50 / ± 100	$55.2\pm5\%$	0.97 ± 5%	6.33	6.33	6.33	0.22	3.60 ± 11.0%
900	± 50 / ± 100	$55.0 \pm 5\%$	1.05 ± 5%	6.15	6.15	6.15	0.28	2.94 ± 11.0%

<sup>1</sup> The validity of ± 100 MHz only applies for DASY v4 4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

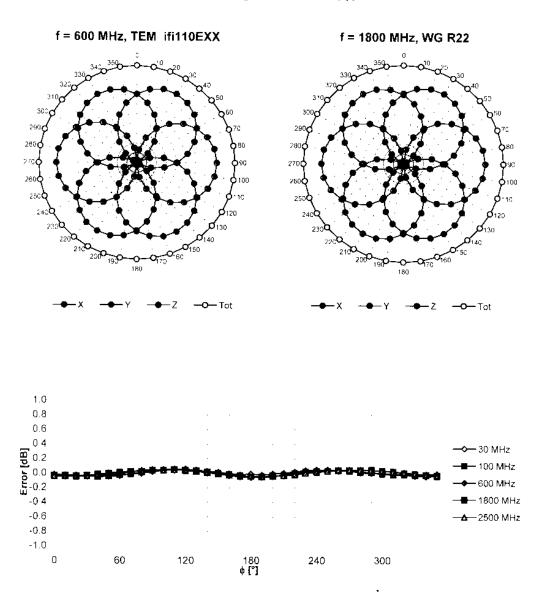
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## **Frequency Response of E-Field**

(TEM-Cell:ifi110 EXX, Waveguide: R22)

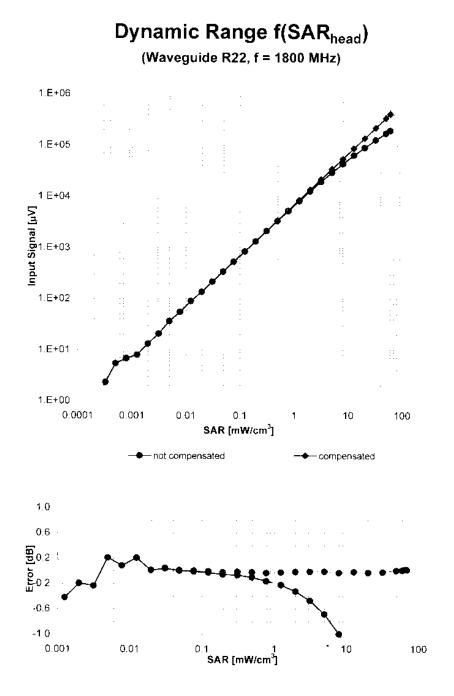


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

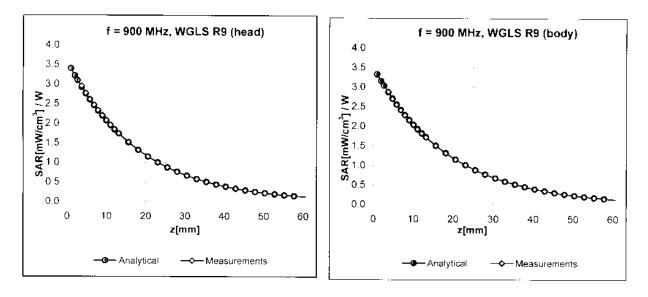


## Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$

Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

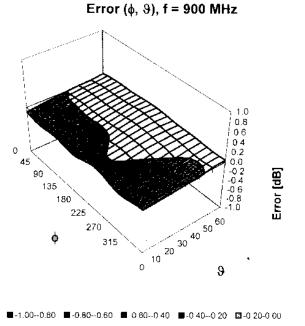


Uncertainty of Linearity Assessment: ± 0.6% (k=2)



## **Conversion Factor Assessment**

## **Deviation from Isotropy in HSL**



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

□ 0.00-0.20 ■ 0.20-0.40 □ 0.40-0.60 ■ 0.60-0.80 ■ 0.80 1.00

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## **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	enabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	4 mm

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Świss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client Celltech

Certificate No: EX3-3600\_Apr10

Accreditation No.: SCS 108

Object	EX3DV4 - SN:3	600	
Calibration procedure(s)		QA CAL-14.v3, QA CAL-23.v3 and edure for dosimetric E-field probes	
Calibration date:	April 29, 2010		
The measurements and the unce	ertainties with confidence	itional standards, which realize the physical uni probability are given on the following pages and	d are part of the certificate.
Calibrations have been condu		ory facility: environment temperature (22 ± 3)°C	; and humidity < 70%.
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
ower meter E4419B	GB41293874	1-Apr-10 (No. 217-01136)	Apr-11
	GB41293874 MY41495277	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136)	
ower sensor E4412A			•
Power sensor E4412A Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	MY41495277 MY41498087	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136)	Apr-11 Apr-11
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	MY41495277 MY41498087 SN: S5054 (3c)	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159)	Арг-11 Арг-11 Маг-11
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09)	Apr-11 Apr-11 Mar-11 Mar-11
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b)	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160)	Apr-11 Apr-11 Mar-11 Mar-11 Mar-11
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09)	Apr-11 Apr-11 Mar-11 Mar-11 Mar-11 Dec-10
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 29-Sep-09 (No. DAE4-660_Sep09)	Apr-11 Apr-11 Mar-11 Mar-11 Mar-11 Dec-10 Sep-10
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4 Secondary Standards RF generator HP 8648C	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 29-Sep-09 (No. DAE4-660_Sep09) Check Date (in house)	Apr-11 Apr-11 Mar-11 Mar-11 Mar-11 Dec-10 Sep-10 Scheduled Check
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4 Secondary Standards RF generator HP 8648C	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 ID # US3642U01700	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 29-Sep-09 (No. DAE4-660_Sep09) Check Date (in house) 4-Aug-99 (in house check Oct-09)	Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Sep-10 Scheduled Check In house check: Oct-1
Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ES3DV2 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 29-Sep-09 (No. DAE4-660_Sep09) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09)	Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Sep-10 Scheduled Check In house check: Oct-1 In house check: Oct-1
Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 20 dB Attenuator Reference Probe ES3DV2 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E Calibrated by:	MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 	1-Apr-10 (No. 217-01136) 1-Apr-10 (No. 217-01136) 30-Mar-10 (No. 217-01159) 30-Mar-10 (No. 217-01161) 30-Mar-10 (No. 217-01160) 30-Dec-09 (No. ES3-3013_Dec09) 29-Sep-09 (No. DAE4-660_Sep09) Check Date (in house) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-09) Eunction	Apr-11 Apr-11 Mar-11 Mar-11 Dec-10 Sep-10 Scheduled Check In house check: Oct-1 In house check: Oct-1

#### Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst

- C Service suisse d'étalonnage
  - Servizio svizzero di taratura
- S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary:

tissue simulating liquid
sensitivity in free space
sensitivity in TSL / NORMx,y,z
diode compression point
crest factor (1/duty_cycle) of the RF signal
modulation dependent linearization parameters
φ rotation around probe axis
9 rotation around an axis that is in the plane normal to probe axis (at measurement center),
i.e., $\theta = 0$ is normal to probe axis

#### Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

#### Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization 9 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx, y, z are only intermediate values, i.e., the uncertainties of NORMx, y, z does not effect the E<sup>2</sup>-field uncertainty inside TSL (see below *ConvF*).
- NORM(f)x, y, z = NORMx, y, z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCPx.y.z:* DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax, y, z; Bx, y, z; Cx, y, z, VRx, y, z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx, y, z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

# Probe EX3DV4

## SN:3600

Manufactured: Last calibrated: Recalibrated:

January 10, 2007 April 28, 2009 April 29, 2010

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

## DASY - Parameters of Probe: EX3DV4 SN:3600

#### **Basic Calibration Parameters**

	Sensor X	Senso <del>r</del> Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)^A$	0.51	0.51	0.40	± 10.1%
DCP (mV) <sup>B</sup>	90.5	88.5	85.2	

#### **Modulation Calibration Parameters**

UID	Communication System Name	PAR		A dB	B dBuV	с	VR mV	Unc <sup>E</sup> (k=2)
10000	cw	0.00	х	0.00	0.00	1.00	300	± 1.5%
			Y	0.00	0.00	1.00	300	
			Z	0.00	0.00	1.00	300	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

 $<sup>^{\</sup>circ}$  The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Pages 5 and 6).

 $<sup>^{\</sup>rm d}$  Numerical linearization parameter: uncertainty not required.

<sup>&</sup>lt;sup>1</sup> Uncertainty is determined using the maximum deviation from linear response applying recatangular distribution and is expressed for the square of the field value.

## DASY - Parameters of Probe: EX3DV4 SN:3600

#### Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] <sup>C</sup>	Permittivity	Conductivity	ConvFX Cor	IVFY Co	กvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	7.79	7.79	7.79	0.74	0.61 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	6.79	6.79	6.79	0.59	0.70 ±11.0%
1950	± 50 / ± 100	$40.0\pm5\%$	$1.40 \pm 5\%$	6.46	6.46	6.46	0.57	0.72 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1. <b>80 ±</b> 5%	6.15	6.15	6.15	0.34	0.89 ±11.0%

<sup>2</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2) The uncertainty is the RSS of the ConvF uncertainty at calibration frequency

and the uncertainty for the indicated frequency band.

## DASY - Parameters of Probe: EX3DV4 SN:3600

#### Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] <sup>C</sup>	Permittivity	Conductivity	ConvFX Co	nvFY Co	nvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	55.0 ± 5%	1. <b>05 ± 5%</b>	7.92	7.92	7.92	0.50	0.77 ± 11.0%
1810	± 50 / ± 100	53.3 ± 5%	1. <b>52 ±</b> 5%	6.47	6.47	6.47	0.70	0.64 ±11.0%
1950	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	6.53	6.53	6.53	0.64	0.67 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	6.24	6.24	6.24	0.43	0.87 ± 11.0%
5200	± 50 / ± 100	49.0 ± 5%	5.30 ± 5%	3.73	3.73	3.73	0.52	1.95 ± 13.1%
5500	± 50 / ± 100	48.6 ± 5%	5.65 ± 5%	3.30	3.30	3.30	0.58	1.95 ± 13.1%
5800	± 50 / ± 100	<b>48.2 ±</b> 5%	6.00 ± 5%	3.44	3.44	3.44	0.63	1.95 ± 13.1%
2450 5200 5500	± 50 / ± 100 ± 50 / ± 100 ± 50 / ± 100	52.7 ± 5% 49.0 ± 5% 48.6 ± 5%	1.95 ± 5% 5.30 ± 5% 5.65 ± 5%	6.24 3.73 3.30	6.24 3.73 3.30	6.24 3.73 3.30	0.43 0.52 0.58	0.87 ± 11.0% 1.95 ± 13.1% 1.95 ± 13.1%

<sup>3</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

#### 1.5 14 1.3 🖕 Frequency response (normalized) 1.2 11 1.0 0.9 0.8 0.7 0.6 0.5 -. . 0 500 1000 1500 2000 2500 3000

## **Frequency Response of E-Field**

(TEM-Cell:ifi110 EXX, Waveguide: R22)

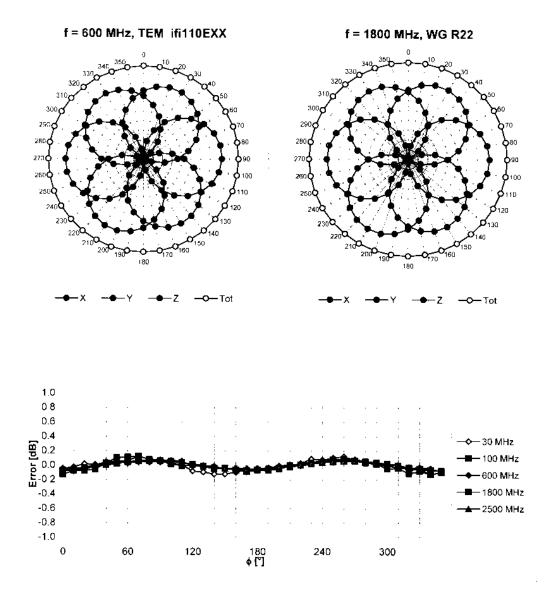
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

-TEM

f [MHz]

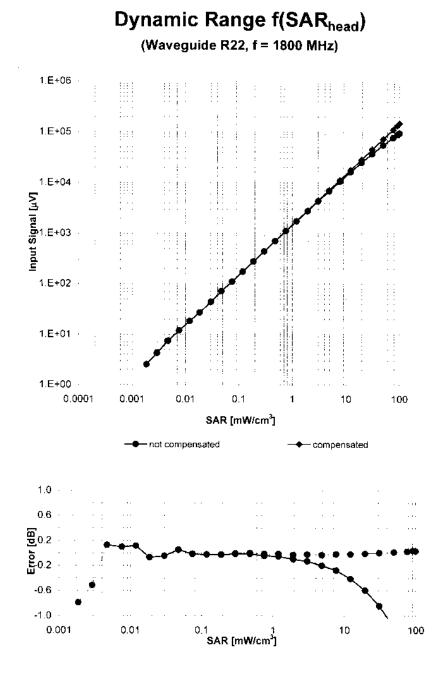
-R22

÷

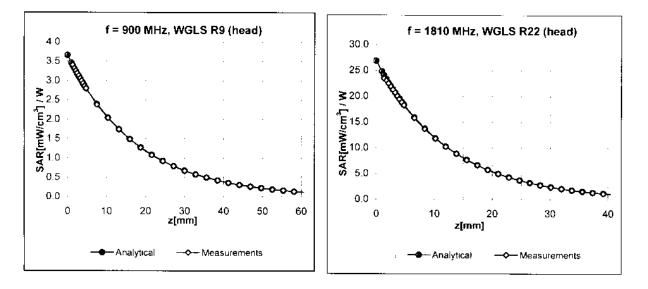


## Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$

Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)



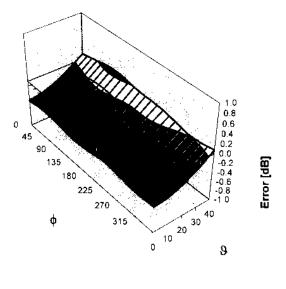
Uncertainty of Linearity Assessment: ± 0.6% (k=2)



### **Conversion Factor Assessment**

## **Deviation from Isotropy in HSL**

Error (φ, ϑ), f = 900 MHz



 ■-1.00--0.80
 ■-0.80--0.60
 ■-0.60--0.40
 ■-0.40--0.20
 ■-0.20-0.00

 □ 0.00-0.20
 ■-0.20-0.40
 □ 0.40-0.60
 ■ 0.60-0.80
 ■ 0.80-1.00

#### Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

## **Other Probe Parameters**

Sensor Arrangement	Triangular				
Connector Angle (°)	Not applicable				
Mechanical Surface Detection Mode	enabled				
Optical Surface Detection Mode	disabled				
Probe Overall Length	337 mm				
Probe Body Diameter	10 mm				
Tip Length	9 mm				
Tip Diameter	2.5 mm				
Probe Tip to Sensor X Calibration Point	1 mm				
Probe Tip to Sensor Y Calibration Point	1 mm				
Probe Tip to Sensor Z Calibration Point	1 mm				
Recommended Measurement Distance from Surface	2 mm				